

DDR2 SDRAM FBDIMM

MT9HTF12872FZ – 1GB

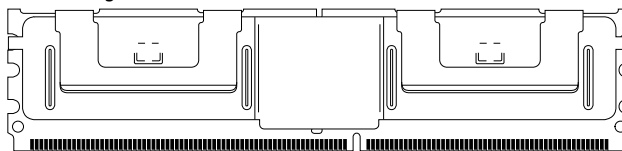
Features

- 240-pin, DDR2 fully-buffered dual in-line memory module (FBDIMM)
- Fast data transfer rates: PC2-5300 or PC2-6400
- 1GB (128 Meg x 72)
- 4.0 Gb/s and 4.8 Gb/s link transfer rates
- High-speed, 1.5V differential, point-to-point link between the host controller and advanced memory buffer (AMB)
- Fault-tolerant; can work around a bad bit lane in each direction
- High-density scaling with up to eight FBDIMMs per channel
- SMBus interface to AMB for configuration register access
- In-band and out-of-band command access
- Deterministic protocol
 - Enables memory controller to optimize DRAM accesses for maximum performance
 - Delivers precise control and repeatable memory behavior
- Automatic DDR2 SDRAM bus and channel calibration
- Transmitter de-emphasis to reduce ISI
- MBIST and IBIST test functions

- Transparent mode for DRAM test support
- $V_{DD} = V_{DDQ} = 1.8V$ for DRAM
- $V_{REF} = 0.9V$ SDRAM command and address termination
- $V_{CC} = 1.5V$ for AMB
- $V_{DDSPD} = 3-3.6V$ for AMB and EEPROM
- Serial presence-detect (SPD) with EEPROM
- Gold edge contacts
- Single rank
- Supports 95°C operation with 2X refresh
- Halogen-free PCB

Figure 1: 240-Pin FBDIMM (MO-256 R/C A)

Module height: 30.35mm (1.19in)



Options

- Package
 - 240-pin DIMM (Halogen-free)
- Frequency/CAS latency
 - 2.5ns @ CL = 5 (DDR2-800)
 - 3.0ns @ CL = 5 (DDR2-667)

Marking

Z
-80E
-667

Table 1: Key Timing Parameters

Speed Grade	Industry Nomenclature	Data Rate (MT/s)				t_{RCD} (ns)	t_{RP} (ns)	t_{RC} (ns)
		CL = 6	CL = 5	CL = 4	CL = 3			
-80E	PC2-6400	800	800	533	400	12.5	12.5	55
-667	PC2-5300	–	667	533	400	15	15	55

Table 2: Addressing

Parameter	1GB
Refresh count	8K
Device bank address	8 BA[2:0]
Device configuration	1Gb (128 Meg x 8)
Row address	16K A[13:0]
Column address	1K A[9:0]
Module rank address	1 S0#

Table 3: Part Numbers and Timing Parameters – 1GB

Base device: MT47H128M8,¹ 1Gb DDR2 SDRAM

Part Number ²	Module Density	Configuration	Module Bandwidth	Memory Clock/ Data Rate	Clock Cycles (CL- ^t RCD- ^t RP)	Link Transfer Rate
MT9HTF12872FZ-80E__	1GB	128 Meg x 72	6.4 GB/s	2.5ns/800 MT/s	5-5-5	4.8 GT/s
MT9HTF12872FZ-667__	1GB	128 Meg x 72	5.3 GB/s	3.0ns/667 MT/s	5-5-5	4.0 GT/s

- Notes:
1. Data sheets for the base devices can be found on Micron's Web page.
 2. All part numbers end with a four-place code (not shown) that designates component, PCB, and AMB revisions. Consult factory for current revision codes. Example: MT9HTF12872FZ-80EM1D4.



1GB (x72, SR) 240-Pin DDR2 SDRAM FBDIMM Pin Assignments and Descriptions

Pin Assignments and Descriptions

Table 4: Pin Assignments

240-Pin FBDIMM Front								240-Pin FBDIMM Back							
Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol
1	V _{DD}	31	PN3	61	PN9#	91	PS9# ¹	121	V _{DD}	151	SN3	181	SN9#	211	SS9# ¹
2	V _{DD}	32	PN3#	62	V _{SS}	92	V _{SS}	122	V _{DD}	152	SN3#	182	V _{SS}	212	V _{SS}
3	V _{DD}	33	V _{SS}	63	PN10	93	PS5	123	V _{DD}	153	V _{SS}	183	SN10	213	SS5
4	V _{SS}	34	PN4	64	PN10#	94	PS5#	124	V _{SS}	154	SN4	184	SN10#	214	SS5#
5	V _{DD}	35	PN4#	65	V _{SS}	95	V _{SS}	125	V _{DD}	155	SN4#	185	V _{SS}	215	V _{SS}
6	V _{DD}	36	V _{SS}	66	PN11	96	PS6	126	V _{DD}	156	V _{SS}	186	SN11	216	SS6
7	V _{DD}	37	PN5	67	PN11#	97	PS6#	127	V _{DD}	157	SN5	187	SN11#	217	SS6#
8	V _{SS}	38	PN5#	68	V _{SS}	98	V _{SS}	128	V _{SS}	158	SN5#	188	V _{SS}	218	V _{SS}
9	V _{CC}	39	V _{SS}	69	V _{SS}	99	PS7	129	V _{CC}	159	V _{SS}	189	V _{SS}	219	SS7
10	V _{CC}	40	PN13 ¹	70	PS0	100	PS7#	130	V _{CC}	160	SN13 ¹	190	SS0	220	SS7#
11	V _{SS}	41	PN13# ¹	71	PS0#	101	V _{SS}	131	V _{SS}	161	SN13# ¹	191	SS0#	221	V _{SS}
12	V _{CC}	42	V _{SS}	72	V _{SS}	102	PS8	132	V _{CC}	162	V _{SS}	192	V _{SS}	222	SS8
13	V _{CC}	43	V _{SS}	73	PS1	103	PS8#	133	V _{CC}	163	V _{SS}	193	SS1	223	SS8#
14	V _{SS}	44	DNU	74	PS1#	104	V _{SS}	134	V _{SS}	164	DNU	194	SS1#	224	V _{SS}
15	V _{TT}	45	DNU	75	V _{SS}	105	DNU	135	V _{TT}	165	DNU	195	V _{SS}	225	DNU
16	DNU	46	V _{SS}	76	PS2	106	DNU	136	DNU	166	V _{SS}	196	SS2	226	DNU
17	RESET#	47	V _{SS}	77	PS2#	107	V _{SS}	137	M_TEST (DNU)	167	V _{SS}	197	SS2#	227	V _{SS}
18	V _{SS}	48	PN12 ¹	78	V _{SS}	108	V _{DD}	138	V _{SS}	168	SN12 ¹	198	V _{SS}	228	SCK
19	DNU	49	PN12# ¹	79	PS3	109	V _{DD}	139	DNU	169	SN12# ¹	199	SS3	229	SCK#
20	DNU	50	V _{SS}	80	PS3#	110	V _{SS}	140	DNU	170	V _{SS}	200	SS3#	230	V _{SS}
21	V _{SS}	51	PN6	81	V _{SS}	111	V _{DD}	141	V _{SS}	171	SN6	201	V _{SS}	231	V _{DD}
22	PN0	52	PN6#	82	PS4	112	V _{DD}	142	SN0	172	SN6#	202	SS4	232	V _{DD}
23	PN0#	53	V _{SS}	83	PS4#	113	V _{DD}	143	SN0#	173	V _{SS}	203	SS4#	233	V _{DD}
24	V _{SS}	54	PN7	84	V _{SS}	114	V _{SS}	144	V _{SS}	174	SN7	204	V _{SS}	234	V _{SS}
25	PN1	55	PN7#	85	V _{SS}	115	V _{DD}	145	SN1	175	SN7#	205	V _{SS}	235	V _{DD}
26	PN1#	56	V _{SS}	86	DNU	116	V _{DD}	146	SN1#	176	V _{SS}	206	DNU	236	V _{DD}
27	V _{SS}	57	PN8	87	DNU	117	V _{TT}	147	V _{SS}	177	SN8	207	DNU	237	V _{TT}
28	PN2	58	PN8#	88	V _{SS}	118	SA2	148	SN2	178	SN8#	208	V _{SS}	238	V _{DDSPD}
29	PN2#	59	V _{SS}	89	V _{SS}	119	SDA	149	SN2#	179	V _{SS}	209	V _{SS}	239	SA0
30	V _{SS}	60	PN9	90	PS9 ¹	120	SCL	150	V _{SS}	180	SN9	210	SS9 ¹	240	SA1

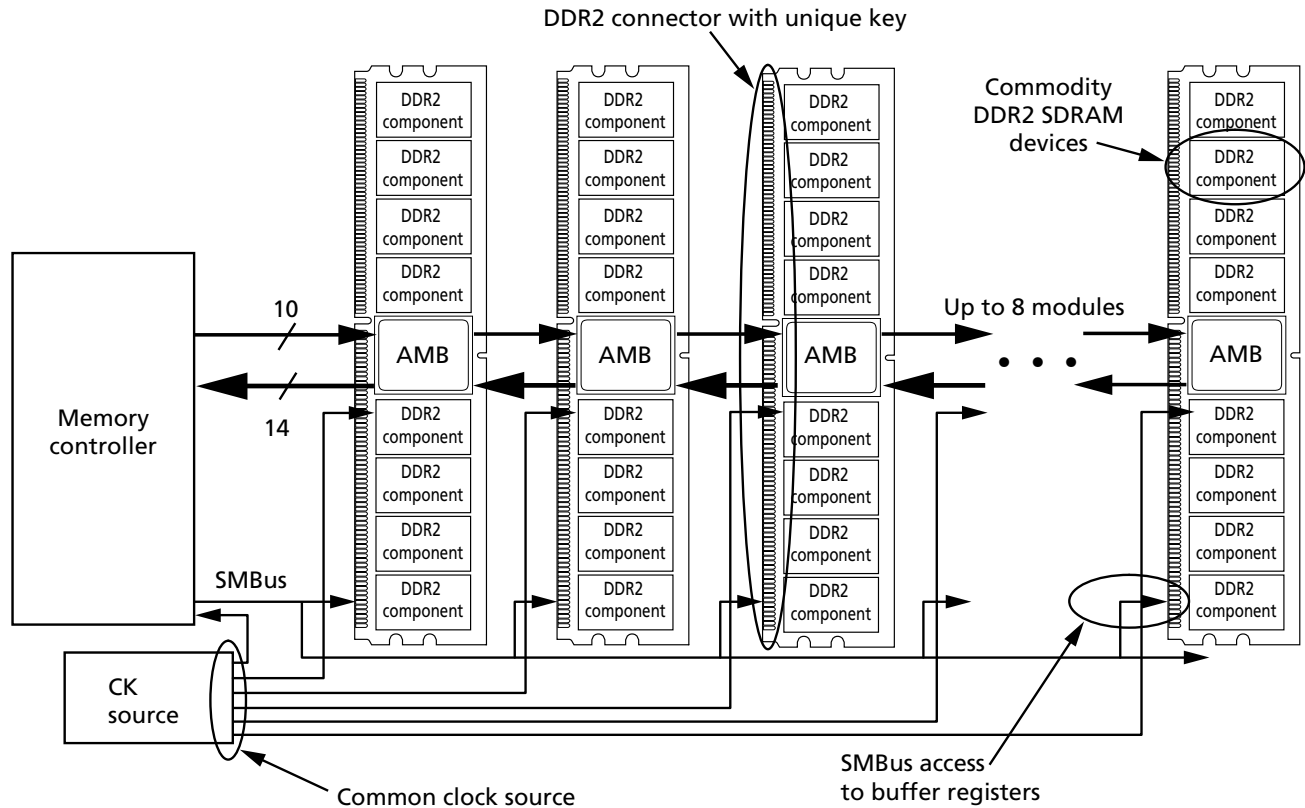
Note: 1. The following signals are cyclical redundancy code (CRC) bits and thus appear out of the normal sequence: PN12/PN12#, SN12/SN12#, PN13/PN13#, SN13/SN13#, PS9/PS9#, SS9/SS9#.

Table 5: Pin Descriptions

Symbol	Type	Description
PS[9:0]	Input	Primary southbound data, positive lines.
PS#[9:0]	Input	Primary southbound data, negative lines.
SCK	Input	System clock input, positive line.
SCK#	Input	System clock Input, negative line.
SCL	Input	Serial presence-detect (SPD) clock input.
SS[9:0]	Input	Secondary southbound data, positive lines.
SS#[9:0]	Input	Secondary southbound data, negative lines.
PN[13:0]	Output	Primary northbound data, positive lines.
PN#[13:0]	Output	Primary northbound data, negative lines.
SN[13:0]	Output	Secondary northbound data, positive lines.
SN#[13:0]	Output	Secondary northbound data, negative lines.
SA[2:0]	I/O	SPD address inputs, also used to select the FBDIMM number in the AMB.
SDA	I/O	SPD data input/output.
RESET#	Supply	AMB reset signal.
V _{CC}	Supply	AMB core power and AMB channel interface power (1.5V).
V _{DD}	Supply	DRAM power and AMB DRAM I/O power (1.8V).
V _{DDSPD}	Supply	SPD/AMB SMBUS power (3.3V).
V _{SS}	Supply	Ground.
V _{TT}	Supply	DRAM address/command/clock termination power (V _{DD} /2).
M_TEST	–	The M_Test pin provides an external connection for testing the margin of V _{REF} , which is produced by a voltage divider on the module. It is not intended to be used in normal system operation and must not be connected (DNU) in a system. This test pin may have other features on future card designs and will be included in this specification at that time.
DNU	–	Do not use.

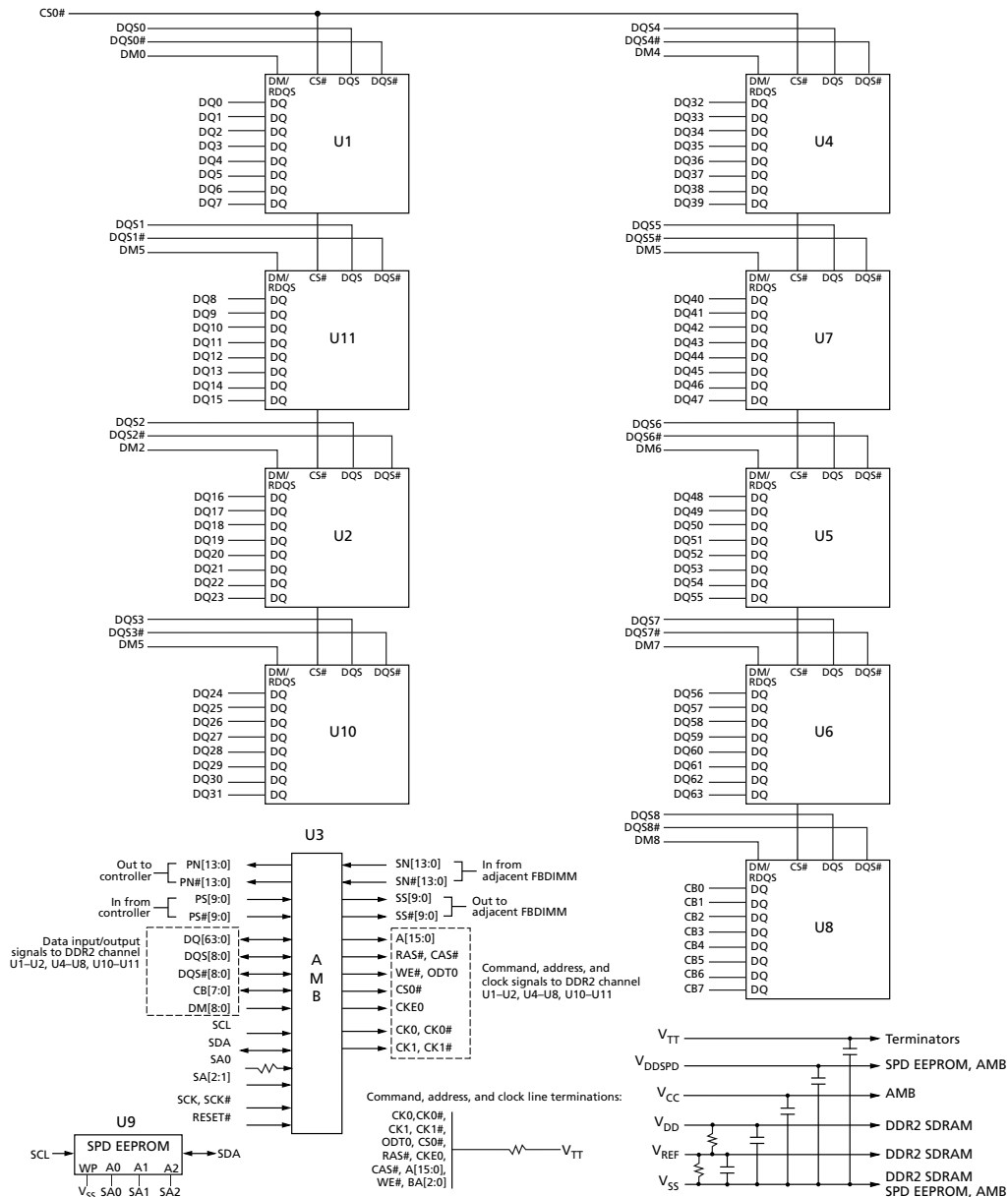
System Block Diagram

Figure 2: System Block Diagram



Functional Block Diagram

Figure 3: Functional Block Diagram



General Description

Micron's FBDIMM devices adhere to the currently proposed industry specifications for FBDIMMs. The following specifications contain detailed information on FBDIMM design, interfaces, and theory of operation and are listed here for the system designers' convenience. Refer to the JEDEC Web site for available specifications.

- FBDIMM Design Specification – pending JEDEC approval
- FBDIMM: Architecture and Protocol – JESD206
- FBDIMM: Advanced Memory Buffer (AMB) – JESD82-20
- Design for Test, Design for Validation (DFx) Specification
- Serial Presence-Detect (SPD) for Fully Buffered DIMM – JEDEC Standard No. 21-C, page 4.1.2.7-1

This DDR2 SDRAM module is a high-bandwidth, large-capacity channel solution that has a narrow host interface. FBDIMM devices use DDR2 SDRAM devices isolated from the channel behind an AMB on the FBDIMM. Memory device capacity remains high, and total memory capacity scales with DDR2 SDRAM bit density.

As shown in the System Block Diagram, the FBDIMM channel provides a communication path from a host controller to an array of DDR2 SDRAM devices, with the DDR2 SDRAM devices buffered behind an AMB device. The physical isolation of the DDR2 SDRAM devices from the channel enhances the communication path and significantly increases the reliability and availability of the memory subsystem.

Advanced Memory Buffer

The AMB isolates the DDR2 SDRAM devices from the channel. This single-chip AMB component, located in the center of each FBDIMM, acts as a repeater and buffer for all signals and commands exchanged between the host controller and DDR2 SDRAM devices, including data input and output. The AMB communicates with the host controller and adjacent FBDIMMs on a system board using an industry-standard, high-speed, differential, 1.5V, point-to-point interface. The AMB also enables buffering of memory traffic to support large memory capacities. Refer to the JEDEC JESD82-20 specification for further information.

Electrical Specifications

Stresses greater than those listed may cause permanent damage to the module. This is a stress rating only, and functional operation of the module at these or any other conditions outside those indicated in the device data sheet is not implied. Exposure to absolute maximum rating conditions for extended periods may adversely affect reliability.

Table 6: Absolute Maximum Ratings

Parameter	Symbol	Min	Max	Units	Notes
Voltage on any pin relative to V_{SS}	V_{IN}, V_{OUT}	-0.3	+1.75	V	1
Voltage on V_{CC} pin relative to V_{SS}	V_{CC}	-0.3	+1.75	V	
Voltage on V_{DD} pin relative to V_{SS}	V_{DD}	-0.5	+2.3	V	
Voltage on V_{TT} pin relative to V_{SS}	V_{TT}	-0.5	+2.3	V	
DDR2 SDRAM device operating case temperature	T_C	0	+95	°C	2, 3
AMB device operating temperature		0	+110	°C	

- Notes:
1. V_{IN} should not be greater than V_{CC} .
 2. T_C is specified at 95°C only when using 2X refresh timing ($t_{REFI} = 7.8\mu s$ at or below 85°C; $t_{REFI} = 3.9\mu s$ above 85°C); refer to the DDR2 SDRAM component data sheet.
 3. See applicable DDR2 SDRAM component data sheet for t_{REFI} and extended mode register settings. The t_{REFI} parameter is used to specify the doubled refresh interval necessary to sustain <85°C operation.

Table 7: Input DC Voltage and Operating Conditions

Parameter	Symbol	Min	Nom	Max	Units	Notes
AMB supply voltage	V_{CC}	1.46	1.5	1.54	V	
DDR2 SDRAM supply voltage	V_{DD}	1.7	1.8	1.9	V	
Termination voltage	V_{TT}	$0.48 \times V_{DD}$	$0.5 \times V_{DD}$	$0.52 \times V_{DD}$	V	
EEPROM supply voltage	V_{DDSPD}	3	3.3	3.6	V	1
SPD input high (logic 1) voltage	$V_{IH(DC)}$	2.1	—	V_{DDSPD}	V	2
SPD input low (logic 0) voltage	$V_{IL(DC)}$	—	—	0.8	V	2
RESET input high (logic 1) voltage	$V_{IH(DC)}$	1	—	—	V	3
RESET input low (logic 0) voltage	$V_{IL(DC)}$	—	—	0.5	V	2
Leakage current (RESET)	I_L	-90	—	+90	μA	3
Leakage current (link)	I_L	-5	—	+5	μA	4

- Notes:
1. Applies to AMB and SPD.
 2. Applies to serial memory buffer (SMB) and SPD bus signals.
 3. Applies to AMB CMOS signal RESET#.
 4. For all other AMB-related DC parameters, please refer to the high-speed differential link interface specification.



1GB (x72, SR) 240-Pin DDR2 SDRAM FBDIMM I_{DD} Conditions and Specifications

Table 8: Clock Rates

FBDIMM Link Data Rate	Reference Clock	DRAM Clock	DRAM Data Rate
3.2 Gb/s	133 MHz	266 MHz	533 Mb/s
4.0 Gb/s	167 MHz	333 MHz	666 Mb/s
4.8 Gb/s	200 MHz	400 MHz	800 Mb/s

Note: 1. DDR2 components may exceed the listed module speed grades; module may not be available in all listed speed grades

I_{DD} Conditions and Specifications

Table 9: I_{DD} Conditions

Symbol	Condition
I _{DD_IDLE_0}	Idle current, single, or last DIMM: L0 state; Idle (0% bandwidth); Primary channel enabled; Secondary channel disabled; CKE HIGH; Command and address lines stable; DDR2 SDRAM clock active
I _{DD_IDLE_1}	Idle current, first DIMM: L0 state; Idle (0% bandwidth); Primary and secondary channels enabled; CKE HIGH; Command and address lines stable; DDR2 SDRAM clock active
I _{DD_ACTIVE_1}	Active power: L0 state; 50% DRAM bandwidth; 67% READ; 33% WRITE; Primary and secondary channels enabled; DDR2 SDRAM clock active; CKE HIGH
I _{DD_ACTIVE_2}	Active power, data pass through: L0 state; 50% DRAM bandwidth to downstream DIMM; 67% READ; 33% WRITE; Primary and secondary channels enabled; DDR2 SDRAM clock active; CKE HIGH; Command and address lines stable
I _{DD_TRAINING}	Training: Primary and secondary channels enabled; 100% toggle on all channel lanes; DRAMs idle; 0% bandwidth; CKE HIGH; Command and address lines stable; DDR2 SDRAM clock active
I _{DD_IBIST}	IBIST over all IBIST modes: DRAM idle (0% bandwidth); Primary channel enabled; Secondary channel enabled; CKE HIGH; Command and address lines stable; DDR2 SDRAM clock active
I _{DD_EI}	Electrical idle: DRAM idle (0% bandwidth); Primary channel disabled; Secondary channel disabled; CKE LOW; Command and address lines floated; DDR2 SDRAM clock active; ODT and CKE driven LOW

Note: 1. Actual test conditions may vary from published JEDEC test conditions.

Table 10: I_{DD} Specifications – 1GB DDR2-667 (Die revision H)

Symbol	I _{DD_IDLE_0}	I _{DD_IDLE_1}	I _{DD_ACTIVE_1}	I _{DD_ACTIVE_2}	I _{DD_TRAINING}	I _{DD_IBIST}	I _{DD_EI}	Units
I _{CC}	2600	3400	3900	3700	4000	4500	2500	mA
I _{DD}	916	916	1945	916	916	916	263	mA
Total power	5.8	7.0	9.8	7.5	8.0	8.8	4.4	W



Table 11: I_{DD} Specifications – 1GB DDR2-667 (Die revision M)

Symbol	I _{DD_IDLE_0}	I _{DD_IDLE_1}	I _{DD_ACTIVE_1}	I _{DD_ACTIVE_2}	I _{DD_TRAINING}	I _{DD_IBIST}	I _{DD_EI}	Units
I _{CC}	2600	3400	3900	3700	4000	4500	2500	mA
I _{DD}	916	916	1945	916	916	916	290	mA
Total power	5.8	7.0	9.8	7.5	8.0	8.8	4.5	W

Table 12: I_{DD} Specifications – 1GB DDR2-800 (All die revisions)

Symbol	I _{DD_IDLE_0}	I _{DD_IDLE_1}	I _{DD_ACTIVE_1}	I _{DD_ACTIVE_2}	I _{DD_TRAINING}	I _{DD_IBIST}	I _{DD_EI}	Units
I _{CC}	TBD	TBD	TBD	TBD	TBD	TBD	TBD	mA
I _{DD}	TBD	TBD	TBD	TBD	TBD	TBD	TBD	mA
Total power	TBD	TBD	TBD	TBD	TBD	TBD	TBD	W

Note: 1. Total power is based on maximum voltage levels, I_{CC} at 1.575V and I_{DD} at 1.9V.

Serial Presence-Detect

For the latest SPD data, refer to Micron's SPD page: www.micron.com/SPD.

Table 13: Serial Presence-Detect EEPROM DC Operating Conditions

Parameter/Condition	Symbol	Min	Max	Units
EEPROM and AMB supply voltage	V _{DDSPD}	3	3.6	V
Input high voltage: Logic 1; all inputs	V _{IH}	V _{DDSPD} × 0.7	V _{DDSPD} + 0.5	V
Input low voltage: Logic 0; all inputs	V _{IL}	–0.6	V _{DDSPD} × 0.3	V
Output low voltage: I _{OUT} = 3mA	V _{OL}	–	0.4	V
Input leakage current: V _{IN} = GND to V _{DD}	I _{LI}	0.10	3	μA
Output leakage current: V _{OUT} = GND to V _{DD}	I _{LO}	0.05	3	μA
Standby current	I _{SB}	1.6	4	μA
Power supply current, READ: SCL clock frequency = 100 kHz	I _{CCR}	0.4	1	mA
Power supply current, WRITE: SCL clock frequency = 100 kHz	I _{CCW}	2	3	mA

Table 14: Serial Presence-Detect EEPROM AC Operating Conditions

Parameter/Condition	Symbol	Min	Max	Units	Notes
SCL LOW to SDA data-out valid	t _{AA}	0.2	0.9	μs	1
Time the bus must be free before a new transition can start	t _{BUF}	1.3	–	μs	
Data-out hold time	t _{DH}	200	–	ns	
SDA and SCL fall time	t _F	–	300	ns	2
Data-in hold time	t _{HD:DAT}	0	–	μs	
Start condition hold time	t _{HD:STA}	0.6	–	μs	
Clock HIGH period	t _{HIGH}	0.6	–	μs	
Noise suppression time constant at SCL, SDA inputs	t _I	–	50	ns	

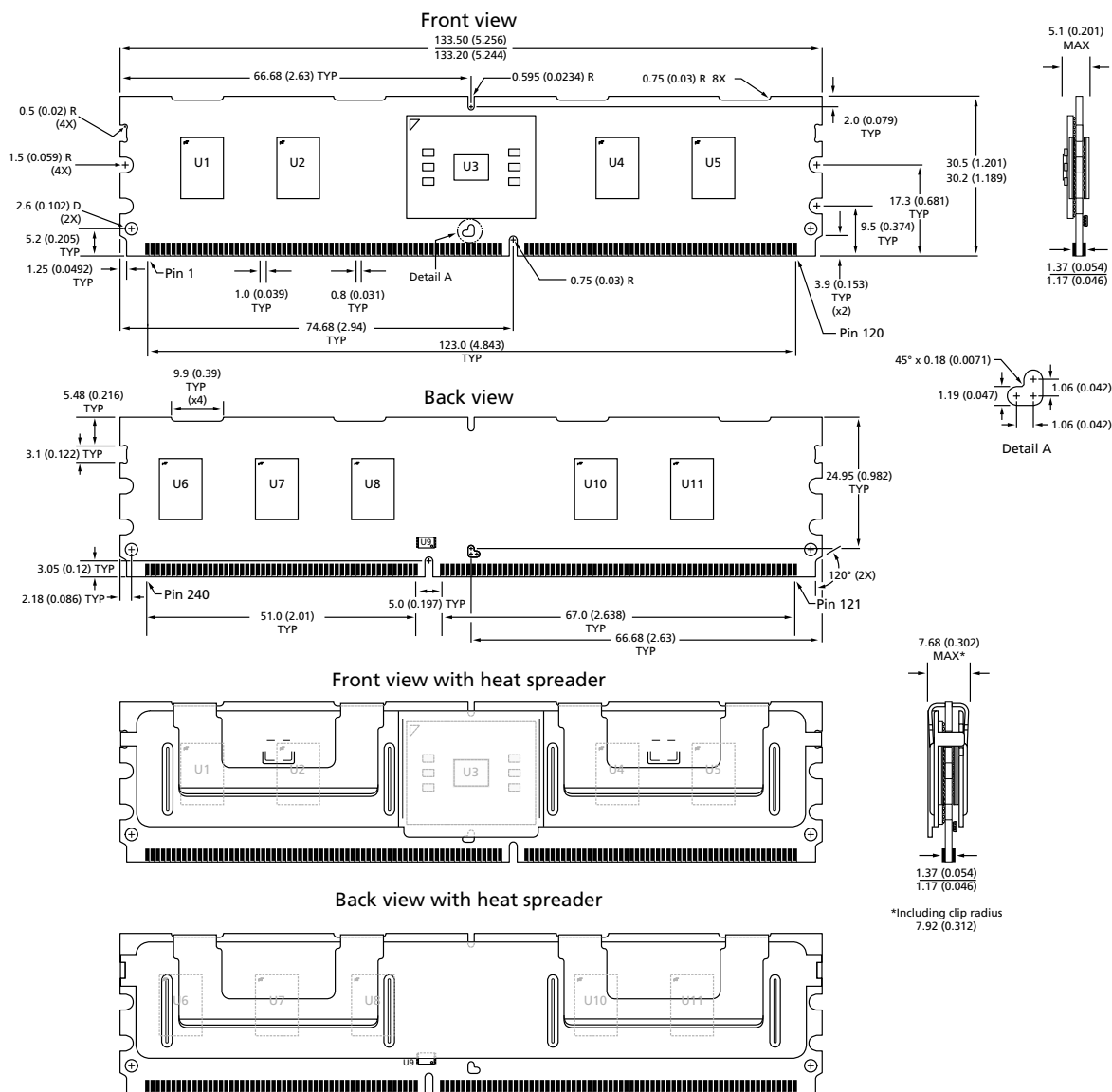
Table 14: Serial Presence-Detect EEPROM AC Operating Conditions (Continued)

Parameter/Condition	Symbol	Min	Max	Units	Notes
Clock LOW period	t_{LOW}	1.3	–	μs	
SDA and SCL rise time	t_{R}	–	0.3	μs	2
SCL clock frequency	f_{SCL}	–	400	kHz	
Data-in setup time	$t_{\text{SU:DAT}}$	100	–	ns	
Start condition setup time	$t_{\text{SU:STA}}$	0.6	–	μs	3
Stop condition setup time	$t_{\text{SU:STO}}$	0.6	–	μs	
WRITE cycle time	t_{WRC}	–	10	ms	4

- Notes:
1. To avoid spurious start and stop conditions, a minimum delay is placed between SCL = 1 and the falling or rising edge of SDA.
 2. This parameter is sampled.
 3. For a restart condition, or following a WRITE cycle.
 4. The SPD EEPROM WRITE cycle time (t_{WRC}) is the time from a valid stop condition of a write sequence to the end of the EEPROM internal ERASE/PROGRAM cycle. During the WRITE cycle, the EEPROM bus interface circuit is disabled, SDA remains HIGH due to pull-up resistance, and the EEPROM does not respond to its slave address.

Module Dimensions

Figure 4: 240-Pin DDR2 FBDIMM



- Notes: 1. All dimensions are in millimeters (inches); MAX/MIN or typical (TYP) where noted.
 2. The dimensional diagram is for reference only. Refer to the JEDEC MO document for additional design dimensions.

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This data sheet contains minimum and maximum limits specified over the power supply and temperature range set forth herein. Although considered final, these specifications are subject to change, as further product development and data characterization sometimes occur.